Search Notes

	Application/Control No.	Applicant(s)/Pate Reexamination	Applicant(s)/Patent under Reexamination	
	10/642,364	JAYALEKSHMY	ET AL.	
ſ	Examiner	Art Unit		
	Anthony Weier	1761		

SEARCHED			
Class	Subclass	Date	Examiner
426	629, 541	3/23/2007	AW
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NO (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
Inventor Search	3/23/2007	AW